

SPECIFICATION FOR CTP MODULE

MODULE NO: YB-TG240320C277A-C-A0

Doc.Version:00

Customer A	Approval:	

□ Accept	□ Reject

YEEBO	NAME	SIGNATURE	DATE
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■ APPROVAL FOR SPECIFICATIONS ONLY

□ APPROVAL FOR SPECIFICATIONS AND SAMPLE

WIMRD005-02-D

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1. Revision History

Sample Version	DOC. Version	DATE		DESCRIPTION	CHANGED BY
A1	00	2021-07-27	SPEC Only	First issue	KAI
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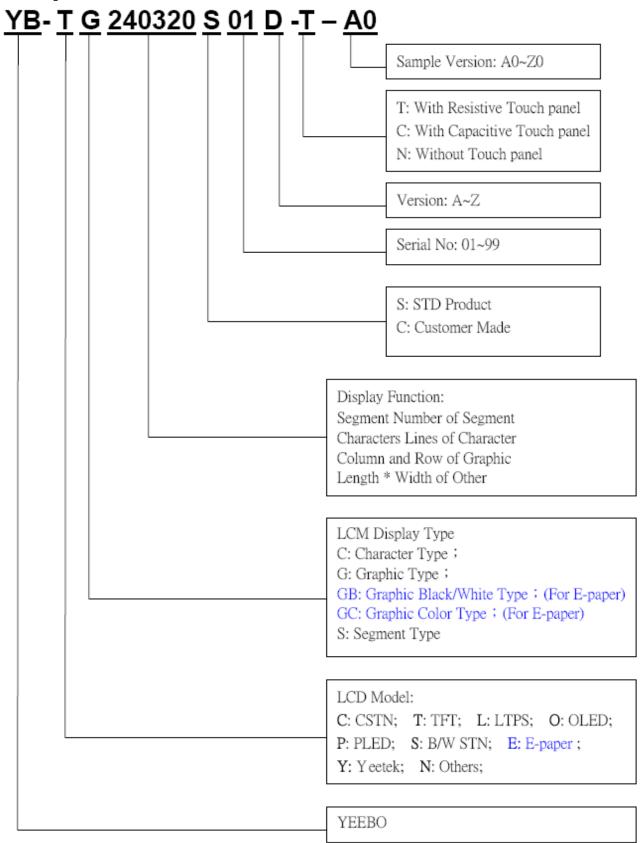
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3. Module Numbering System:

(Example)



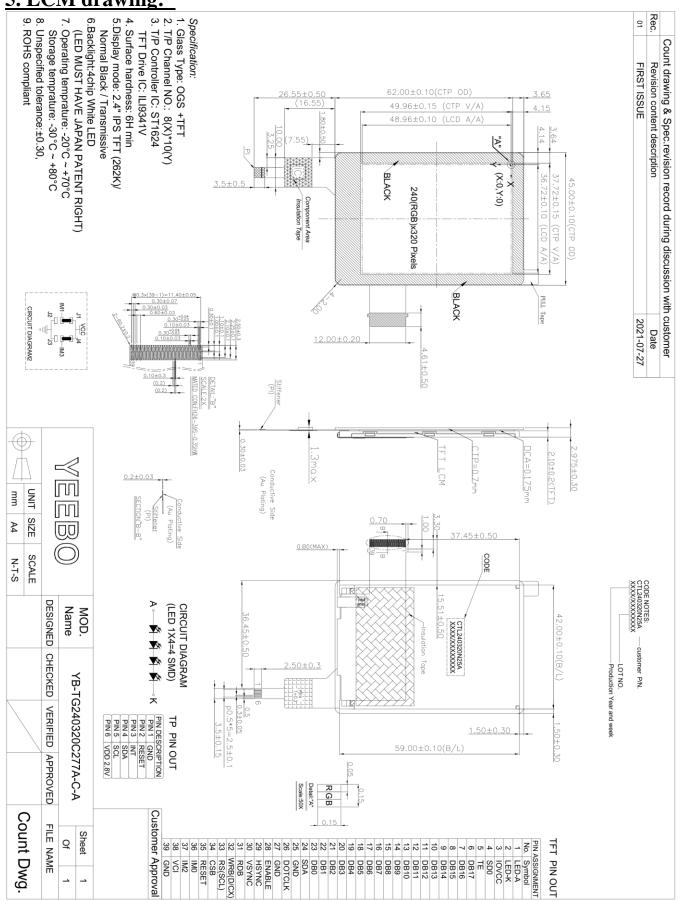


4. General Specification:

ITEM	CONTENTS
Module Size	45.0 (W) * 62.0 (H) * 2.975 (T) mm
Display Size(Diagonal)	2.4 inch
Display Format	240(RGB)*320 Pixels
Active Area	36.72(W) * 48.96 (H) mm
Pixel Pitch	0.153 * 0.153 mm
LCD Type	TFT (262K) / Transmissive / Normally Black
View Angle	Free
Controller IC	ILI9341V
CTP IC	ST1624
Weight	TBD



5. LCM drawing:





6. Electrical Characteristics

6-1 Absolute Maximum Ratings

6-1-1 TFT Absolute Maximum Ratings

(Ta=25°C VSS=0V)

Item	Symbol	Min.	Type	Max.	Unit	Remark
Supply Voltage	$V_{\rm CI}$	-0.3	-	+4.6	Volt	Note1
Supply Voltage(Logic)	IOV_{CC}	-0.3	-	+4.6	Volt	Note1
Operating Temperature	Topr	-20	-	+70	°C	-
Storage Temperature	Tstg	-30	-	+80	°C	-

Note1: Absolute maximum rating is the limit value beyond which the IC maybe broken. They do not assure operations.

6-1-1 TP Absolute Maximum Ratings

 $(Ta=25^{\circ}C\ VSS=0V)$

Parameter	Symbol	Min.	Max.	Unit
VDD	V_{VDD}	-0.3	+6	V
IOVDD	VIOVDD	-0.3	+6 🕢	V
Operating Ambient Temperature	T _A	-20	+80	3
Storage Temperature	Ts	-40	+125	ာ

Note: Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. All the ranges are stress ratings only. Functional operation of this device at these or any other conditions above those indicated in the operational sections of this specification is not implied or intended. Exposed to the absolute maximum rating conditions for extended periods may affect device reliability.

6-2 Operating Conditions

6-2-1 TFT Operating Conditions

(Ta=25°C)

Item	Symbol	Condition	Min.	Тур.	Max.	Unit
Power Supply voltage	$V_{\rm CI}$	-	2.5	2.8	3.3	Volt
Supply voltage for I/O	IOV _{CC}	-	1.65	2.8	3.3	Volt
Input Voltage	V_{IH}	-	0.7 * IOV _{CC}	-	IOV _{CC}	V
input voitage	V_{IL}	-	Vss	-	0.3* IOV _{CC}	V
Power Supply Current for LCM	Icc	V _{CI} =2.8V	-	6.83	10.25	mA



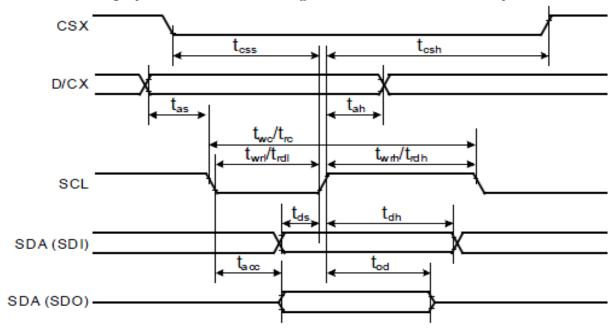
6-2-2 TP Operating Conditions

Condition: VDD = IOVDD = 3.3V, TA = 25°C, unless be specified individually.

Parameter	Symbol	Min.	Тур.	Max.	Unit	Condition
VDD	Vvdd	2.7		3.6	7	
IOVDD	VIOVDD	1.6	16	3.6	V	
Operating Current	I _{NML}	-	2.8	-/)	mA	
Idle Current	I _{IDLE}	-	900	<u> </u>	uA	
Smart Wake Up Current	Iswu	-{\	105	-	uA	
Power Down Current	IPD			20	uA	
Input High Voltage	VIH	0.85*I OVDD	-	-	>	
Input Low Voltage	Vid		-	0.15*I OVDD	٧	
Input Pull Up Resistor	Rpu	50	-	60	KOhm	
Output Driving Current	lorv	6	1	-	mA	V _{OH} = IOVDD x 0.8
Output Sinking Current	Isink	10	ı	-	mA	Vol = IOVDD x 0.2
Low Voltage Reset	V _{LVR}	-	-	2.3	V	

6-3 TFT Timing Characteristics

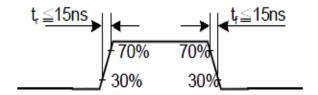
6-3-1 Display Serial Interface Timing Characteristics (4-line SPI system)





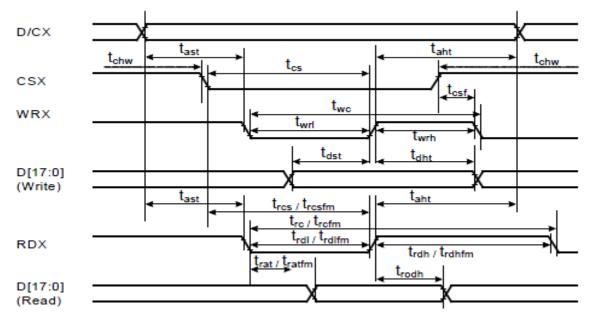
Signal	Symbol	Parameter	min	max	Unit	Description
CSX	tcss	s Chip select time (Write)		-	ns	
COA	tcsh	Chip select hold time (Read)	40	-	ns	
	twc	Serial clock cycle (Write)	100	-	ns	
	twrh	SCL "H" pulse width (Write)	40	-	ns	
SCL	twrl	SCL "L" pulse width (Write)	40	-	ns	
SCL	trc	Serial clock cycle (Read)	150	-	ns	
	trdh	SCL "H" pulse width (Read)	60	-	ns	
	trdl	SCL "L" pulse width (Read)	60	-	ns	
DICY	tas	D/CX setup time	10	-		
D/CX	tah	D/CX hold time (Write / Read)	10	-		
SDA / SDI	tds	Data setup time (Write)	30	-	ns	
(Input)	tdh	Data hold time (Write)	30	-	ns	
SDA/SDO	tacc	Access time (Read)	10	-	ns	For maximum CL=30pF
(Output)	tod	Output disable time (Read)	10	50	ns	For minimum CL=8pF

Note: Ta = 25 °C, VDDI=1.65V to 3.3V, VCI=2.5V to 3.3V, AGND=VSS=0V



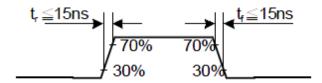


6-3-2 Display Parallel 18/16/9/8-bit Interface Timing Characteristics (8080- ■ system)



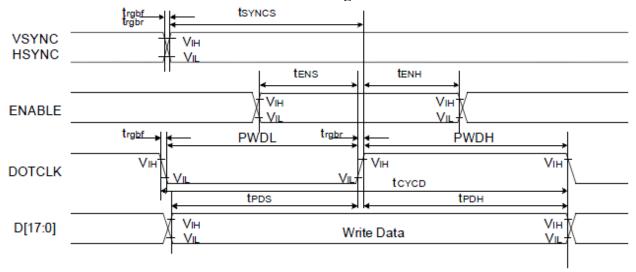
Signal	Symbo	Parameter	min	max	Unit	Description
DCX tast		Address setup time	0	-	ns	
	taht	Address hold time (Write/Read)	0	-	ns	
	tchw	CSX "H" pulse width	0	-	ns	
	tcs	Chip Select setup time (Write)	15	-	ns	
CSX	trcs	Chip Select setup time (Read ID)	45	-	ns	
	trcsfm	Chip Select setup time (Read FM)	355	-	ns	
	tcsf	Chip Select Wait time (Write/Read)	10	-	ns	
	twc	Write cycle	66	-	ns	
WRX	twrh	Write Control pulse H duration	15	-	ns	
	twrl	Write Control pulse L duration	15	-	ns	
	trcfm	Read Cycle (FM)	450	-	ns	
RDX (FM)	trdhfm	Read Control H duration (FM)	90	-	ns	
	trdlfm	Read Control L duration (FM)	355	-	ns	
	trc	Read cycle (ID)	160	-	ns	
RDX (ID)	trdh	Read Control pulse H duration	90	-	ns	
	trdl	Read Control pulse L duration	45	-	ns	
D(47-0)	tdst	Write data setup time	10	-	ns	
D[17:0],	tdht	Write data hold time	10	-	ns	For maximum CL=30pF
D[17:10]&D[8:1], D[17:10],	trat	Read access time	-	40	ns	For minimum CL=30PF
D[17:10], D[17:9]	tratfm	Read access time	-	340	ns	For minimum CL-ope
D[11.8]	trod	Read output disable time	20	80	ns	

Note: Ta = -30 to 70 °C, VDDI=1.65V to 3.3V, VCI=2.5V to 3.3V, VSS=0V.



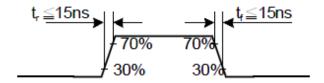


6-3-3 Parallel 18/16/6-bit RGB Interface Timing Characteristics



Signal	Symbol	Parameter	min	max	Unit	Description
VSYNC /	tsyncs	VSYNC/HSYNC setup time	15	_	ns	
HSYNC	t _{synch}	VSYNC/HSYNC hold time	15	-	ns	
DE	tens	DE setup time	15	-	ns	
DE	t _{ENH}	DE hold time	15	-	ns	
D[17:0]	tpos	Data setup time	15	-	ns	18/16-bit bus RGB
D[17.0]	t _{PDH}	Data hold time	15	_	ns	interface mode
	PWDH	DOTCLK high-level period	15	-	ns	
DOTCLK	PWDL	DOTCLK low-level period	15	-	ns	
DOTCER	toyop	DOTCLK cycle time	100	-	ns	
t _{rgbr} , t _{rgbr}		DOTCLK,HSYNC,VSYNC rise/fall time	-	15	ns	
VSYNC /	tsyncs	VSYNC/HSYNC setup time	15	-	ns	
HSYNC	tsynch	VSYNC/HSYNC hold time	15	-	ns	
DE	tens	DE setup time	15	-	ns	
DE	t _{ENH}	DE hold time	15	-	ns	
D[17:0]	tpos	Data setup time	15	-	ns	6-bit bus RGB
D[17.0]	t _{PDH}	Data hold time	15	_	ns	interface mode
	PWDH	DOTCLK high-level pulse period	15	-	ns]
DOTCLK	PWDL	DOTCLK low-level pulse period	15	-	ns	
DOTCER	tcyco	DOTCLK cycle time	50	-	ns	
	trabr , trabr	DOTCLK,HSYNC,VSYNC rise/fall time	-	15	ns	

Note: $Ta = -30 \text{ to } 70 \,^{\circ}\text{C}$, VDDI = 1.65 V to 3.3 V, VCI = 2.5 V to 3.3 V, AGND = VSS = 0 V





6-4 TP AC Electrical Characteristics

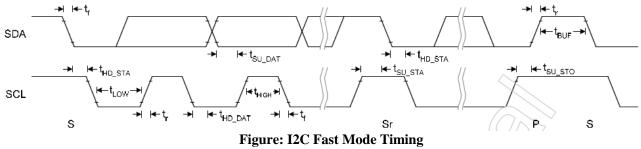


Table : I2C Fast Mode Timing Characteristic

Symbol	Parameter		Rating		Unit
Cymbol	1 diameter	Min.	Тур.	Max.	Oilit
f _{SCL}	SCL clock frequency	0		400	kHz
t_{LOW}	Low period of the SCL clock	1.3		-	us
t _{HIGH}	High period of the SCL clock	0.6)) ′ -	-	us
t _f	Signal falling time		-	300	ns
t _r	Signal rising time		-	300	ns
t _{SU_STA}	Set up time for a repeated START condition	0.6	-	-	us
t _{HD_STA}	Hold time (repeated) START condition. After this period, the first clock pulse is generated	0.6	-	-	us
t _{SU_DAT}	Data set up time	100	-	-	ns
t _{HD DAT}	Data hold time	0	-	0.9	us
t _{su_sto}	Set up time for STOP condition	0.6	-	-	us
t _{BUF}	Bus free time between a STOP and START condition	1.3	-	-	us
Сь	Capacitive load for each bus line	-	-	400	рF



7. Optical Characteristics:

Item		Crush ol	Canditions	Spe	cificat	ions	Unit	Note
		Symbol	Conditions	Min	Тур	Max	Unit	Note
Transmittance (With PL)		T(%)	_	-	4.65	-	-	-
(**************************************	_/		0.0					
Contrast Ratio		CR	⊖=0 Normal Viewing angle	640	800	-		(1) (2)
Response	time	TR+TF	_	-	35	45	ms	(1) (3)
	How	Өх+		-	80	-		
Viewing Hor		Өх-	CD> 10	-	80	-		
angle	Vor	Өу+	CR≧ 10	-	80	-	deg.	-
	Ver	Өу-		-	80	-		

Measuring Condition

Measuring surrounding: dark room
 Ambient temperature: 25±2°C

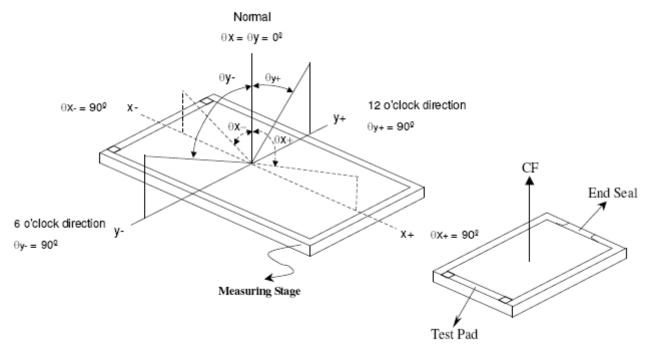
3. 30 min. Warm-up time.

Color of CIE Coordinate:

Item		Symbol	Condition	Min.	Тур.	Max.
	D 1	X		0.624	0.644	0.664
	Red	у		0.311	0.331	0.351
Characticites	Green	X	0 1 00	0.319	0.339	0.359
Chromaticity Coordinates		y	$\theta = \phi = 0^{\circ}$ LED Backlight	0.579	0.599	0.619
(Transmissive)	Blue	X	LED Backlight	0.123	0.143	0.163
(Transmissive)		у		0.048	0.068	0.088
	XX71-:4-	X		0.294	0.314	0.334
	White	у		0.315	0.335	0.355



Note (1) Definition of Viewing Angle:

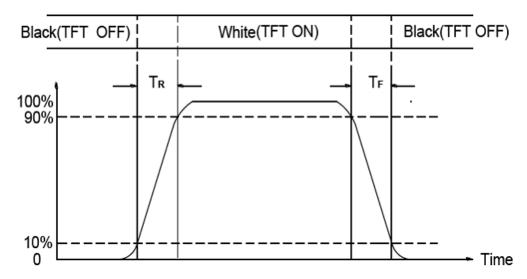


Note (2) Definition of Contrast Ratio(CR): measured at the center point of panel

Contrast ratio (CR)= Photo detector output when LCD is at "White" state

Photo detector output when LCD is at "Black

Note (3) Definition of Response Time: Sum of TR and TF





8. Interface Pin Assignment: 8-1 LCM Interface

No.	Symbol	Function
1	LED_A	LED power anode
2	LED_K	LED power cathode
3	IOVCC	Digital power supply
4	SDO	Serial data output signal
5	TE	Tearing effect output pin (No connection)
6	DB17	Data bus
7	DB16	Data bus
8	DB15	Data bus
9	DB14	Data bus
10	DB13	Data bus
11	DB12	Data bus
12	DB11	Data bus
13	DB10	Data bus
14	DB9	Data bus
15	DB8	Data bus
16	DB7	Data bus
17	DB6	Data bus
18	DB5	Data bus
19	DB4	Data bus
20	DB3	Data bus
21	DB2	Data bus
22	DB1	Data bus
23	DB0	Data bus
24	SDA	Serial data input signal
25	GND	Ground
26	DOTCLK	Pixel clock signal in RGB I/F mode



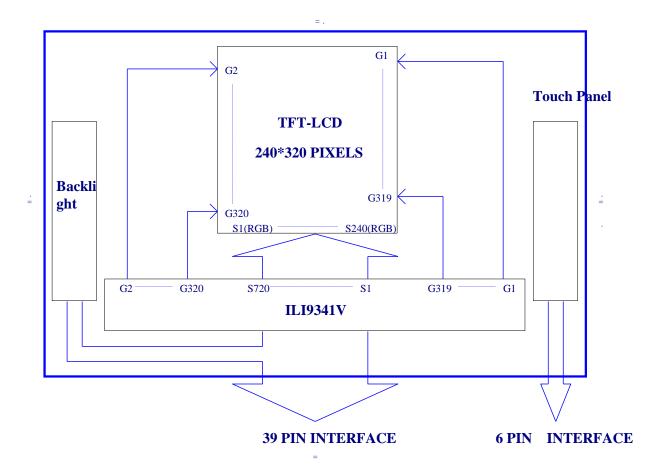
27	GND	Groui	Ground										
28	ENABLE	Data	Data enable signal in RGB I/F mode										
29	HSYNC	Horiz	ontal	synd	c. Sig	nal in RGB I/F mode							
30	VSYNC	Vertic	al sy	nc. S	Signa	I in RGB I/F mode							
31	RDB	Read	sign	al in	80-se	eries parallel interface							
32	WRB	Write	sign	al in	80-se	eries parallel interface							
33	RS	Data/	Com	man	d sele	ect signal							
34	CSB	Chip	selec	t sig	nal								
35	RESET	Rese	Reset signal										
		Selec	t MC	U In	terfac	e mode							
	IM3 IM2 IM1 IM0 MCU-Interface Mode 1 0 1 0 Interface II						10.40	IN/13 IN/12	18.44	IMO	NACI I Interfere Mede	DB Pin in u	se
36		Register/content	GRAM										
		IMO	1	0	1	0		D[8:1]	D[17:0]				
	IM2		0	1	1	80 MCU 9-bit bus Interface II	D[17:10]	D[17:9]					
37		1	1 1 1		0	4-wire 8-bit data serial	SDI: in						
		Interface II SOO: out											
38	VCI	Analo	g po	wer	suppl	у							
39	GND	Groui	Ground										

8-2 TP Interface

No.	Symbol	Function
1	GND	Ground
2	RESET	System reset signal input, active low
3	INT	Indicate coordinate data ready
4	SCA	I2C Serial Data
5	SCL	I2C Serial Clock
6	VDD 2.8V	Power supply



9. Block Diagram:





10. Backlight:

- 1. Standard Lamp Styles (Edge Lighting Type):
 The LED chips are distributed over the edge light area of the illumination unit, which gives the less power consumption:
- 2. The Main Advantages of the LED Backlight are as following:
 - 2.1 The brightness of the backlight can simply be adjusted. By a resistor or a potentiometer.

3. Data About LED Backlight:

 $(Ta=25^{\circ}C)$

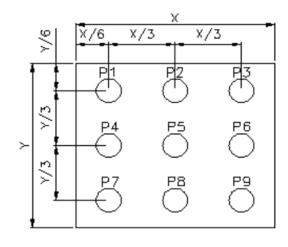
PARAMETER	Sym.	Min.	Тур.	Max.	Unit	Test Condition	Note
Supply Current	I	ı	20	ı	mA	V=12.0V	
Supply Voltage	V	11.0	12.0	13.2	>	lf=20mA	
Luminous Intensity	IV	350	450	ı	Cd/m ²	If=20mA	2
Uniformity for LCM	-	70	ı	-	%	If=20mA	3
Life Time	-	-	50000	-	Hr.	If=20mA	4
Color				Wh	ite		

NOTE:

- 1. Backlight Only
- 2. Average Luminous Intensity of P1-P9
- 3. Uniformity = Min/Max * 100%
- 4. LED life time defined as follows: The final brightness is at 50% of original brightness

Measured Method: (X*Y: Light Area)

Internal Circuit Diagram





(Effective spatial Distribution)

Using aperture of 1°, distance 50cm.



11. Standard Specification for Reliability: 11–1. Standard Specifications for Reliability of LCD Module

No	Item	Description
01	High temperature operation	The sample should be allowed to stand at 70°C for 120 hours under driving condition and then returning it to normal temperature condition, and allowing it stand for 2 hours.
02	Low temperature operation	The sample should be allowed to stand at -20°C for 120 hours under driving condition and then returning it to normal temperature condition, and allowing it stand for 2 hours.
03	High temperature storage	The sample should be allowed to stand at 80°C for 120 hours under no-load condition, and then returning it to normal temperature condition, and allowing it stand for 2 hours.
04	Low temperature storage	The sample should be allowed to stand at -30°C for120 hours under no-load condition, then returning it to normal temperature condition, and allowing it stand for 2 hours.
05	Moisture storage	The sample should be allowed to stand at 60°C,90%RH MAX for 120 hours under no-load condition, then taking it out and drying it at normal temperature for 2 hours.
06	Thermal shock storage	The sample should be allowed to stand the following 10 cycles: -30° C for 30 minutes \rightarrow normal temperature for 5 minutes \rightarrow +80°C for 30 minutes \rightarrow normal temperature for 5 minutes, as one cycle.
07	Packing vibration	Frequency range: 10Hz ~ 55Hz Amplitude of vibration: 1.5mm X,Y,Z 2 hours for each direction. Sweep time: 12 min
08	Packing drop test	According to ISTA 1A 2001.
09	Electrical Static	Air: ± 4 KV 150pF/330 Ω 5 times
	Discharge	Contact: $\pm 2KV \ 150pF/330\Omega \ 5$ time

^{*}Sample size for each test item is 3~5pcs



11 - 2. Testing Conditions and Inspection Criteria

For the final test the testing sample must be stored at room temperature for 24 hours, after the tests listed in Table 12-1, Standard specifications for Reliability have been executed in order to ensure stability.

No	Item	Test Model	In section Criteria
01	Current Consumption	Refer To Specification	The current consumption should conform to the product specification.
02	Contrast	Refer To Specification	After the tests have been executed, the contrast must be larger than half of its initial value prior to the tests.
03	Appearance	Visual inspection	Defect free.

11-3. MTBF

MTBF	Functions, performance, appearance, etc. shall be free from remarkable deterioration within 50,000 hours under ordinary operating and storage conditions room temperature (25 \pm 5 $^{\circ}$ C), normal humidity (50 \pm 10% RH), and in area not exposed to direct sun light.
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12. Specification of Quality Assurance:

12-1. Purpose

This standard for Quality Assurance should affirm the quality of LCD module products to supply to purchaser by YEEBO CORPORATION (Supplier).

12-2. Standard for Quality Test

a. Inspection:

Before delivering, the supplier should take the following tests, and affirm the quality of product.

b. Electro-Optical Characteristics:

According to the individual specification to test the product.

c. Test of Appearance Characteristics:

According to the individual specification to test the product.

d. Test of Reliability Characteristics:

According to the definition of reliability on the specification for testing products.

e. Delivery Test:

Before delivering, the supplier should take the delivery test.

- (i) Test method: According to MIL-STD105E.General Inspection Level II take a single time.
- (ii) The defects classify of AQL as following:

Major defect: AQL = 0.65 Minor defect: AQL = 2.5 Total defects: AQL = 2.5

12-3. Non- conforming Analysis & Deal With Manners

- a. Non-conforming Analysis:
 - (i) Purchaser should supply the detail data of non- conforming sample and the non-conforming.
 - (ii) After accepting the detail data from purchaser, the analysis of non- conforming should be finished in two weeks.
- (iii) If supplier can not finish analysis on time, must announce purchaser before 3 days.
- b. Disposition of non-conforming:
 - (i) If find any product defect of supplier during assembly time, supplier must change the good product for every defect after recognition.
 - (ii) Both supplier and customer should analyze the reason and discuss the disposition of non-conforming when the reason of nonconforming is not sure.
- 12-4. Agreement items

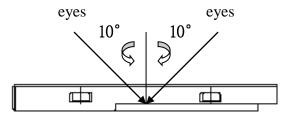
Both sides should discuss together when the following problems happen.

- a. There is any problem of standard of quality assurance, and both sides should think that must be modified.
- b. There is any argument item which does not record in the standard of quality assurance.
- c. Any other special problem.

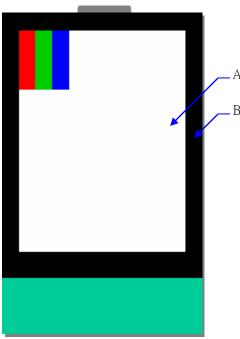


12-5. Standard of The Product Appearance Test

- a. Manner of appearance test:
- (i) The test must be under $20W \times 2$ or 40W fluorescent light, and the distance of view must be at $30\pm5cm$.
 - (ii) When test the model of transmissive product must add the reflective plate.
 - (iii)The test direction is base on around 10° of vertical line.
 - (iiii)Temperature: 25±5°C Humidity: 60±10%RH



(iv) Definition of area:



- A. Area: Viewing area.
- B. Area: Out of viewing area. (Outside viewing area)
- b. Basic principle:
 - (i) It will accord to the AQL when the standard can not be described.
 - (ii) The sample of the lowest acceptable quality level must be discussed by both supplier and customer when any dispute happened.
 - (iii) Must add new item on time when it is necessary.
 - c. Standard of inspection: (Unit: mm)



12-6. Inspection specification

Defect out of viewing area can be neglected.

NO	Item	Criterion							
01	Electrical Testing	 1.1 Missing vertical, horizontal segment, segment contrast defect. 1.2 Missing character, dot or icon. 1.3 Display malfunction. 1.4 No function or no display. 1.5 Current consumption exceeds product specifications. 1.6 LCD viewing angle defect. 1.7 Mixed product types. 1.8 Flicker 							
02	Black or White spots or Bright spots or Color spots on LCD (Display only)	Five spots. 2.2 Densely spaced: 2.3 Not visible throu	 2.1 White and black or color spots on display ≤ 0.25mm, no more than Five spots. 2.2 Densely spaced: No more than three spots within 3mm. 2.3 Not visible through 5% ND filter 						
03	LCD and Touch Panel black spots, white spots, contamination	3.1 Round type: As $\Phi = (X+Y)/2$ $X \leftarrow \frac{1}{X}$ $X \leftarrow \frac{1}{X}$ $X \leftarrow \frac{1}{X}$ $Y \leftarrow \frac{1}{X}$ * Definition of the expectation of t	ensely spaced:	Size(mm) $Φ \le 0.10$ $0.10 < Φ \le 0.20$ $0.20 < Φ \le 0.25$ $0.25 < Φ \le 0.30$ 0.30 < Φ No more than two	Acceptable Q'ty Accept no dense 2 2 1 0 spots within 3mm.	2.5			
	(non – display)	→ L ₩	Length(mm) $$ $L \leq 3.0$ $L \leq 2.5$ $$	$\begin{array}{c} \text{Width(mm)} \\ \text{W} \! \leq \! 0.02 \\ \\ 0.02 \! < \! \text{W} \! \leq \! 0.05 \\ \\ 0.03 \! < \! \text{W} \! \leq \! 0.15 \\ \\ 0.15 \! < \! \text{W} \end{array}$	Acceptable Q'ty Accept no dense 2 Rejection o lines within 3mm.	2.5			



NO	Item	Criterion			AQL
04	Polarizer bubbles	If bubbles are visible, judge using black spot specifications, not easy to find, must check in specify direction	Size Φ(mm) $Φ \le 0.20$ $0.20 < Φ \le 0.50$ $0.50 < Φ \le 1.00$ $1.00 < Φ$ Total Q'ty	Acceptable Q'ty Accept no dense 3 2 0 3	2.5
05	Scratches	Follow NO.3 -2 Line Type.			
06	Mura	Not visible through 5% ND filter Symbols: x: Chip length y: Chip wick: Seal width t: Glass the L: Electrode pad length 7.1 General glass chip: 7.1.1 Chip on panel surface and compared to the compared to t	th z: Chip thinickness a: LCD side track between panels $x \le x$ and $x \le x \le x$ is the total length of $x \le x \le x$ is the total length of $x \le x \le x$ and $x \le x \le x \le x$ is the total length of $x \le x \le x \le x$ is the total length of $x \le x \le x \le x$ is the total length of $x \le x \le x \le x$ is the total length of $x \le x \le x \le x$.	le length length 1/8a 1/8a each chip	2.5
	 ⊙ Unit: mm ⊙ If there are 2 or more chips, x is the total length of each chip 				



NO	Item	Criterion		
	ПСШ	Symbols: x: Chip length y: Chip width z: Chip thickness k: Seal width t: Glass thickness a: LCD side length L: Electrode pad length 8.1 Protrusion over terminal: 8.1.1 Chip on electrode pad:		
		y: Chip width x : Chip length z : Chip thickness $y \le 0.5 \text{mm}$ $x \le 1/8 \text{a}$ $0 < z \le t$		
		8.1.2 Non-conductive portion:		
08	Glass crack	y Z Z X	2.5	
		y: Chip width x: Chip length z: Chip thickness		
		$y \le L \qquad x \le 1/8a \qquad 0 < z \le t$		
		 If there chipped area touches the ITO terminal, over 2/3 of the ITO must remain and be inspected according to electrode terminal specifications. If the product will be heat sealed by the customer, the alignment mark must mot be damaged. 8.1.3 Substrate protuberance and internal crack 		
		y: width x: length		
		$y \le 1/3L$ $X \le a$		



NO	Item	Criterion		
09	Cracked glass	The LCD with extensive crack is not acceptable.		
10	Backlight elements	 10.1 Illumination source flickers when lit. 10.2 Spots or scratches that appear when lit must be judged. Using LCD spot, lines and contamination standards. 10.3 Backlight doesn't light or color is wrong. 		
11	Bezel	Bezel must comply with product specifications.	2.5	
12	PCB、COB	 12.1 COB seal may not have pinholes larger than 0.2mm or contamination. 12.2 COB seal surface may not have pinholes through to the IC. 12.3 The height of the COB should not exceed the height indicated in the assembly diagram. 12.4 There may not be more than 2mm of sealant outside the seal area on PCB. And there should be no more than three places. 12.5 Parts on PCB must be the same as on the production characteristic chart, There should be no wrong parts, missing parts or excess parts. 12.6 The jumper on the PCB should conform to the product characteristic chart. 	2.5 2.5 2.5 2.5 0.65	
13	FPC	13.1 FPC terminal damage \leq 1/2 FPC terminal width and can not affect the function, we judge accept. 13.2 FPC alignment hole damage \leq 1/2 alignment area and can not affect the function, we judge accept.	2.5	
14	Soldering	14.1 No cold solder joints, missing solder connections, oxidation or icicle.14.2 No short circuits in components on PCB or FPC.	2.5 0.65	



NO	Item	Criterion AQ			AQL	
NO 15	Touch Panel Chipped glass	z: Chip thickness Z≦t ○ Unit: mm ○ If there are 2 or m 15.1.2 Corner crack:	y: Chip width t: Touch Panel Total togth hip: surface and crack between y: Chip width ≤ 1/2 k and not over viewing area nore chips, x is the total in	een panels: x : Chip length $x \le 1/8a$ length of each chip		AQL 2.5
		z: Chip thickness	y: Chip width	x: Chip length		
		z≦t	$\leq 1/2$ k and not over viewing area	x≤1/8a		
		⊙ Unit: mm⊙ If there are 2 or m	nore chips, x is the total	length of each chip		



NO	Item	Criterion		
16	Touch Panel(Fish eye、dent and bubble on film)	$\begin{array}{ c c c }\hline SIZE(mm) & Acceptable Q'ty\\ \hline \Phi \leq 0.2 & Accept no dense\\ \hline 0.2 < D \leq 0.4 & 5\\ \hline 0.4 < D \leq 0.5 & 2\\ \hline 0.5 < D & 0\\ \hline \end{array}$	2.5	
17	Touch Panel Newton ring	Newton ring dimension $\leq 1/2$ touch panel area and not affect font and line distortion($\leq 2.5\%$), it is acceptable.	2.5	
18	Touch Panel Linearity	Less than 2.5% is acceptable.		
19	LCD Ripple	Touch the touch panel, can not see the LCD ripple. Pen: R 1.0mm silicon rubber. Operation Force: 80g		
20	General appearance	 20.1 Pin type must match type in specification sheet. 20.2 LCD pin loose or missing pins. 20.3 Product packaging must the same as specified on packaging specification sheet. 20.4 Product dimension and structure must conform to product specification sheet. 		



13. Handling Precaution:

13-1 Handling of LCM

- Don't give external shock.
- Don't apply excessive force on the surface.
- Liquid in LCD is hazardous substance. Must not lick and swallow. when the liquid is attach to your hand, skin, cloth etc. Wash it out thoroughly and immediately.
- Don't operate it above the absolute maximum rating.
- Don't disassemble the LCM.
- The operators should be grounded whenever he/she comes into contact with the module. Never touch any of the conductive parts such as the LSI pads, the copper leads on the PCB and the interface terminals with any parts of the human body.
- The modules should be kept in antistatic bags or other containers resistant to static for storage.
- The module is coated with a film to protect the display surface. Be care when peeling off this protective film since static electricity may be generated.

13-2 Storage

- Store in an ambient temperature of 25±10°C, and in a relative humidity of 50±10%RH. Don't expose to sunlight or fluorescent light.
- Storage in a clean environment, free from dust, active gas, and solvent.
- Store in anti-static electricity container.
- Store without any physical load.

13-3 Soldering

- Use only soldering irons with proper grounding and no leakage.
- Iron: No higher than 280±10°C and less than 3 sec during Hand soldering.
- Rewiring: no more than 2 times.



14. Warranty

This product has been manufactured to specifications as a part for use in your company's general electronic products. It is guaranteed to perform according to delivery specifications. For any other use apart from general electronic equipment, we will not take responsibility if the product is used in medical devices, nuclear power control equipment, aerospace equipment, fire and security systems, or any other applications in which there is a direct risk to human life and where extremely high levels of reliability are required. If the product is to be used in any of the above applications, we will need to enter into a separate product liability agreement.

- 1. We cannot accept responsibility for any defect arise after additional process of the product (including disassembly and reassembly), after product delivery.
- 2. We cannot accept responsibility for any defect, which may arise after the application of strong external force to the product.
- 3. We cannot accept responsibility for any defect, which may arise due to the application of static electricity after the product has passed your company's acceptance inspection procedures.
- 4. We can not accept responsibility for industrial property, which may arise through the use of your product, with exception to those issues relating directly to the structure or method of manufacturing of our product within one year from YEEBO shipment.
- 5. For Heatseal Product which required to heatseal by customer side, parts must be used within three months after delivery from factory.
- 6. For TAB Product which required to solder by customer side, parts must be used within three months after delivery from factory.
- 7. The liability of YB is limited to repair or replacement on the terms set forth below. YB will not be responsible for any subsequent or consequential events or injury or damage to any personnel or user including third party personnel and/or user. Unless otherwise agreed in writing between YB and the customer, YB will only replace or repair any of its LCD which is found defective electrically or visually when inspected in accordance with YB GENERAL LCD INSPECTION STANDARD.

15. Guarantee:

Our products meet requirements of the environment.

YEEBO ROHS requirement is based on European Union Directive 2011/65/EU (ROHS) Requirements and Update.